

**Notice of References Cited**

Application/Control No.

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Applicant(s)/Patent Under  
Reexamination  
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Examiner

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Art Unit

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Page 1 of 1

**U.S. PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
A	US-6140725	11-2000	Jensen et al.	310/87
B	US-6081056	06-2000	Takagi et al.	310/89
C	US-6169345 B1	01-2002	Bloch et al.	310/67R
D	US-6276475 B1	08-2002	Nakanosono	180/65.8
E	US-6005312	12-1999	Yamane	310/67R
F	US-			
G	US-			
H	US-			
I	US-			
J	US-			
K	US-			
L	US-			
M	US-			

**FOREIGN PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N					
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**NON-PATENT DOCUMENTS**

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